Search Notes	Application/Control No. 10/022,622	Applicant(s)/Patent under Reexamination KIM, KI-TAEK	
	Examiner Feben M. Haile	Art Unit 2663	

SEARCHED			
Class	Subclass	Date	Examiner
370	389	2/3/2006	FH
370	395.1	2/3/2006	FH
370	395.7	2/3/2006	FH
370	395.71	2/3/2006	FH
370	412	2/3/2006	FH
370	413	2/3/2006	FH
370	395.6	2/3/2006	FH

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Search: atm, cell, fifo, SOC, synchronization, buffer, memory, queue, storage, utopia, discard, remove	2/3/2006	FH
Updated Search	6/1/2006	FH

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner